

STS2DPF80

DUAL P-CHANNEL 80V - 0.21 Ω - 2.3A SO-8 STripFETTM POWER MOSFET

TYPE	V _{DSS}	R _{DS(on)}	I _D
STS2DPF80	80 V	<0.25 Ω	2.3 A

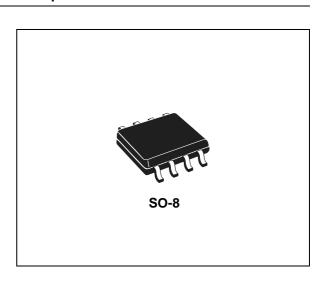
- TYPICAL $R_{DS}(on) = 0.21 \Omega$
- STANDARD OUTLINE FOR EASY AUTOMATED SURFACE MOUNT ASSEMBLY

DESCRIPTION

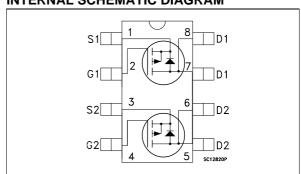
This application specific Power MOSFET is the second generation of STMicroelectronis unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

APPLICATIONS

- DC/DC CONVERTERS
- BATTERY MANAGEMENT IN NOMADIC EQUIPMENT
- POWER MANAGEMENT IN CELLULAR
 PHONES AND DISPLAY NEW GENERATION



INTERNAL SCHEMATIC DIAGRAM



Ordering Information

SALES TYPE	MARKING	PACKAGE	PACKAGING
STS8DPF80	S8DPF80	SO-8	TAPE & REEL

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source Voltage (V _{GS} = 0)	80	V
V_{DGR}	Drain-gate Voltage (R _{GS} = 20 kΩ)	80	V
V _{GS}	Gate- source Voltage	± 20	V
I _D	Drain Current (continuous) at T _C = 25°C Single Operation Drain Current (continuous) at T _C = 100°C Single Operation	2.0 1.3	A A
I _{DM} (●)	Drain Current (pulsed)	8	Α
P _{tot}	Total Dissipation at T _C = 25°C	2.5	W
T _{stg}	Storage Temperature	-55 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area.

Note: For the P-CHANNEL MOSFET actual polarity of voltages and current has to be reversed

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TAB.1 THERMAL DATA

Rthj- _{PCB} (*) Thermal Resistance Junction-PCB	62.5	°C/W
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^(*) When Mounted on 1 inch2 FR-4 board, 2 oz of Cu and t [10 sec.

ELECTRICAL CHARACTERISTICS (T_{CASE} = 25 °C UNLESS OTHERWISE SPECIFIED)

TAB.2 OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _(BR) DSS	Drain-source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	80			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating T_{C} = 125°C			1 10	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20 V			±100	nA

TAB.3 ON (*)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = 250 \mu A$	2		4	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10 V	I _D = 1 A		0.21	0.25	Ω

TAB.4 DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
gfs (*)	Forward Transconductance	$V_{DS} = 10V$ $I_D = 1 A$		4		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25V$, $f = 1 MHz$, $V_{GS} = 0$		739 89.5 31		pF pF pF

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ELECTRICAL CHARACTERISTICS (continued)

TAB.5 SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on Delay Time Rise Time	$\begin{aligned} &V_{DD} = 40 \text{ V} & I_D = 1 \text{ A} \\ &R_G = 4.7 \Omega & V_{GS} = 10 \text{ V} \\ &(\text{Resistive Load, Figure 1}) \end{aligned}$		13.5 18		ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V_{DD} = 64V I_{D} = 2A V_{GS} =10V (See test circuit, Figure 2)		20 2.5 4.9		nC nC nC

TAB.6 SWITCHING OFF

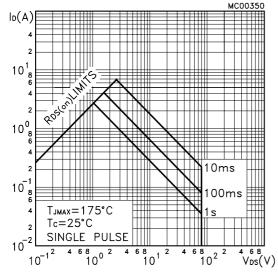
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(off)}	Turn-off Delay Time Fall Time	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		32 13		ns ns

TAB.7 SOURCE DRAIN DIODE

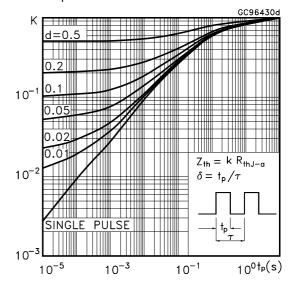
Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (•)	Source-drain Current Source-drain Current (pulsed)				2.3 9.2	A A
V _{SD} (*)	Forward On Voltage	I _{SD} = 1 A V _{GS} = 0			1.2	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 2 \text{ A}$	•	47 87 3.7		ns nC A

^(*)Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %.
(•)Pulse width limited by safe operating area.

Safe Operating Area

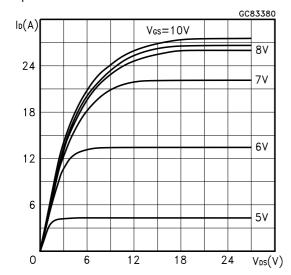


Thermal Impedance

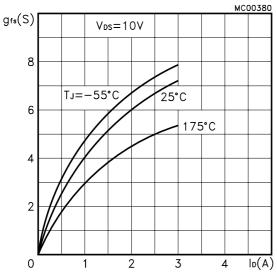


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Output Characteristics

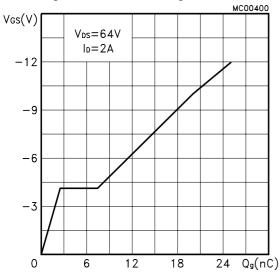


Transconductance

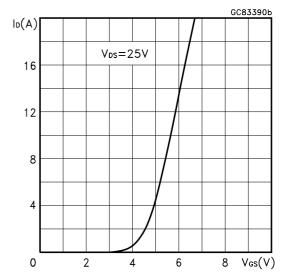


Gate Charge vs Gate-source Voltage

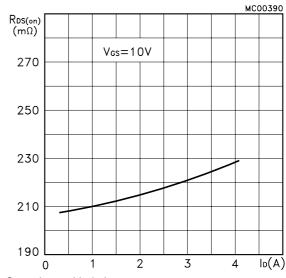
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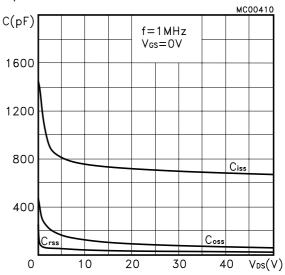
Transfer Characteristics



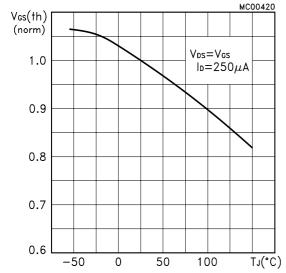
Static Drain-source On Resistance



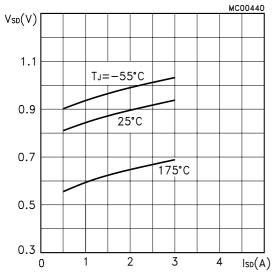
Capacitance Variations



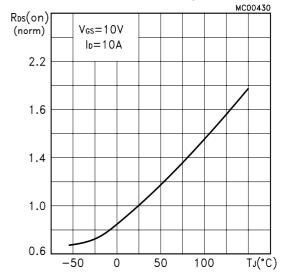
Normalized Gate Threshold Voltage vs Temperature



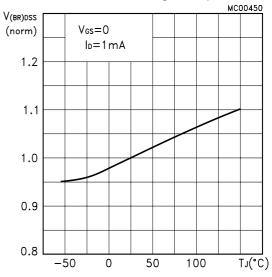
Source-drain Diode Forward Characteristics



Normalized on Resistance vs Temperature



Normalized Breakdown Voltage Temperature.



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Fig. 1: Switching Times Test Circuits For Resistive Load

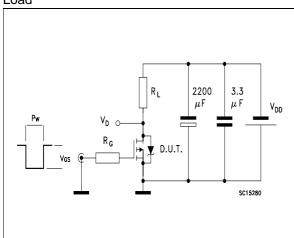


Fig. 2: Gate Charge test Circuit

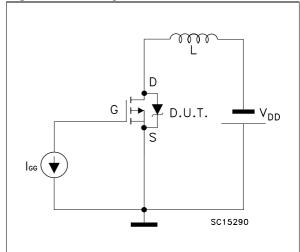
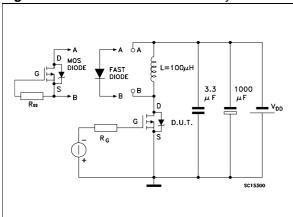


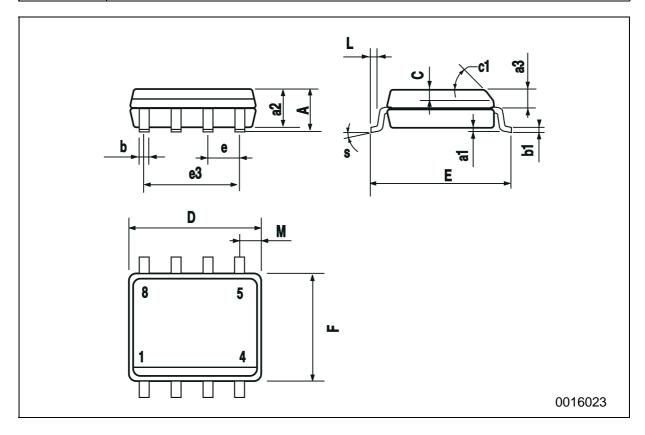
Fig. 3: Test Circuit For Diode Recovery Behaviour



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SO-8 MECHANICAL DATA

DIM.		mm			inch	
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
а3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45 ((typ.)		
D	4.8		5.0	0.188		0.196
Е	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023
S			8 (n	nax.)		



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Revision History

Date	Revision	Description of Changes
Wednesday 16 June 2004	0.1	FIRST ISSUE

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